



## U74LVC126A

CMOS IC

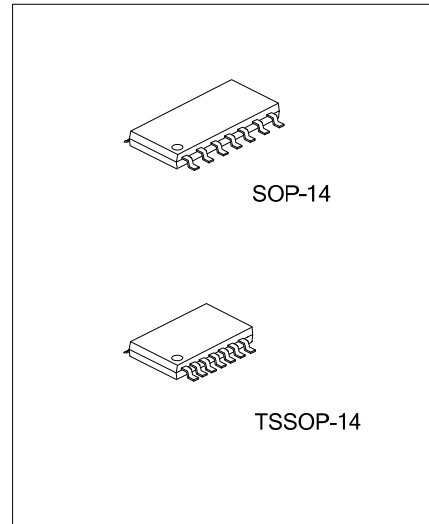
### QUADRUPLE BUS BUFFER GATES WITH 3-STATE OUTPUTS

#### DESCRIPTION

The **U74LVC126A** are quadruple bus buffer gates featuring independent line drivers with 3-state outputs. When OE is low, the nY outputs are in a high-impedance state. When OE is high, the device passes non-inverted data from the nA input to its nY output.

To ensure the high-impedance state during power up or power down, OE should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Inputs can be driven from either 3.3V to 5V devices. This feature allows the use of these devices as translators in a mixed 3.3V/5V system environment.



#### FEATURES

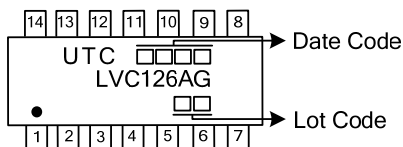
- \* 1.65V to 3.6V V<sub>CC</sub> Operation
- \* Max t<sub>PD</sub> of 4.7ns from A to Y at V<sub>CC</sub> = 3.3V, C<sub>L</sub> = 50pF, R<sub>L</sub> = 500Ω
- \* ±24mA output driver at 3V

#### ORDERING INFORMATION

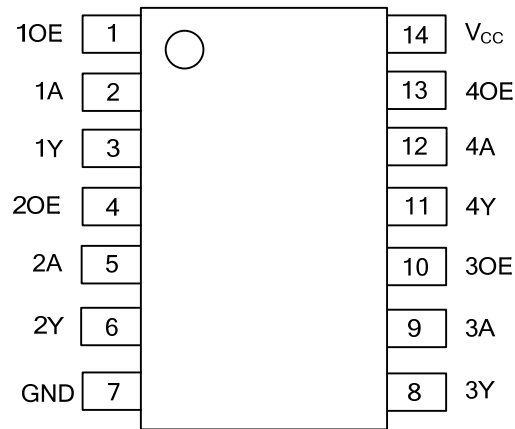
Ordering Number	Package	Packing
U74LVC126AG-S14-R	SOP-14	Tape Reel
U74LVC126AG-P14-R	TSSOP-14	Tape Reel

<p>U74LVC126AG-S14-R</p> <p>(1) Packing Type</p> <p>(2) Package Type</p> <p>(3) Green Package</p>	<p>(1) R: Tape Reel</p> <p>(2) S14: SOP-14, P14: TSSOP-14</p> <p>(3) G: Halogen Free and Lead Free</p>
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#### MARKING



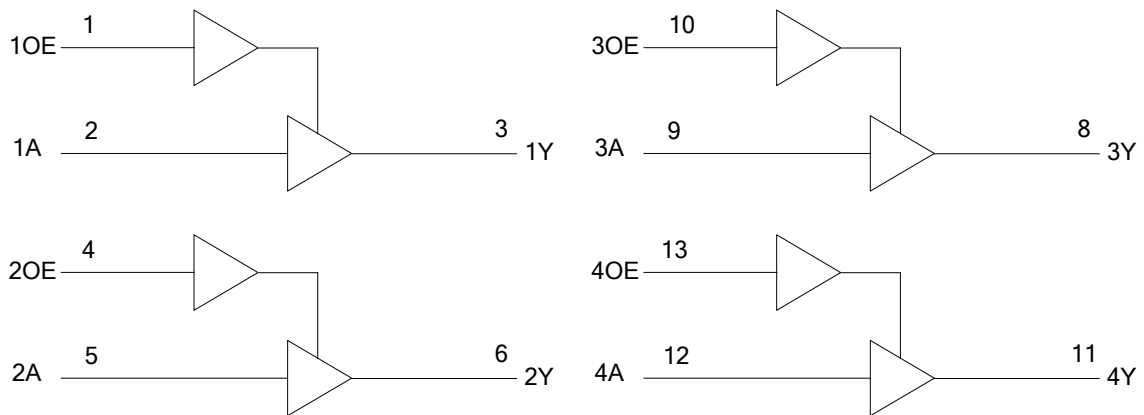
■ PIN CONFIGURATION



■ FUNCTION TABLE

INPUT		OUTPUT
OE	A	Y
H	H	H
H	L	L
L	X	Z

■ LOGIC DIAGRAM (positive logic)



■ ABSOLUTE MAXIMUM RATING (unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	$V_{CC}$	-0.5~6.5	V
Input Voltage	$V_{IN}$	-0.5~6.5	V
Output Voltage	$V_{OUT}$	-0.5~ $V_{CC}$ +0.5	V
Input Clamp Current ( $V_{IN}<0$ )	$I_{IK}$	-50	mA
Output Clamp Current ( $V_{OUT}<0$ , or $V_{OUT}>V_{CC}$ )	$I_{OK}$	-50	mA
Output Current	$I_{OUT}$	±50	mA
$V_{CC}$ or GND Current	$I_{CC}$	±100	mA
Power Dissipation	$P_D$	500	mW
Storage Temperature	$T_{STG}$	-65 ~ +150	°C

Note: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junctions to Ambient	$\theta_{JA}$	86	°C/W
		113	

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	$V_{CC}$	Operating	1.65		3.6	V
		Data retention only	1.5			
High-Level Input Voltage	$V_{IH}$	$V_{CC} = 1.65V$ to $1.95V$	$V_{CC} \times 0.65$			V
		$V_{CC} = 2.3V$ to $2.7V$	1.7			
		$V_{CC} = 2.7V$ to $3.6V$	2			
Low-Level Input Voltage	$V_{IL}$	$V_{CC} = 1.65V$ to $1.95V$			$V_{CC} \times .35$	V
		$V_{CC} = 2.3V$ to $2.7V$			0.7	
		$V_{CC} = 2.7V$ to $3.6V$			0.8	
Input Voltage	$V_{IN}$		0		5.5	V
Output Voltage	$V_{OUT}$		0		$V_{CC}$	V
High-Level Output Current	$I_{OH}$	$V_{CC} = 1.65V$			-4	mA
		$V_{CC} = 2.3V$			-8	
		$V_{CC} = 2.7V$			-12	
		$V_{CC} = 3V$			-24	
Low-Level Output Current	$I_{OL}$	$V_{CC} = 1.65V$			4	mA
		$V_{CC} = 2.3V$			8	
		$V_{CC} = 2.7V$			12	
		$V_{CC} = 3V$			24	
Input Transition Rise or Fall Rate	$\Delta t/\Delta V$		0		10	ns/V
Operating Temperature	$T_A$		-40		85	°C

■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub> =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Output Voltage	V <sub>OH</sub>	I <sub>OH</sub> = -100μA, V <sub>CC</sub> = 1.65V to 3.6V	V <sub>CC</sub> -0.2			V
		I <sub>OH</sub> = -4mA, V <sub>CC</sub> = 1.65V	1.2			
		I <sub>OH</sub> = -8mA, V <sub>CC</sub> = 2.3V	1.7			
		I <sub>OH</sub> = -12mA, V <sub>CC</sub> = 2.7V	2.2			
		I <sub>OH</sub> = -12mA, V <sub>CC</sub> = 3V	2.4			
		I <sub>OH</sub> = -24mA, V <sub>CC</sub> = 3V	2.3			
Low-Level Output Voltage	V <sub>OL</sub>	I <sub>OL</sub> = 100μA, V <sub>CC</sub> = 1.65V to 3.6V			0.1	V
		I <sub>OL</sub> = 4mA, V <sub>CC</sub> = 1.65V			0.45	
		I <sub>OL</sub> = 8mA, V <sub>CC</sub> = 2.3V			0.7	
		I <sub>OL</sub> = 12mA, V <sub>CC</sub> = 2.7V			0.4	
		I <sub>OL</sub> = 24mA, V <sub>CC</sub> = 3V			0.55	
Input Leakage Current (A or OE input)	I <sub>I(LEAK)</sub>	V <sub>IN</sub> = 5.5V or GND, V <sub>CC</sub> = 3.6V			±1	μA
High-impedance state Current	I <sub>OZ</sub>	V <sub>OUT</sub> = V <sub>CC</sub> or GND, V <sub>CC</sub> = 3.6V			±1	μA
Quiescent Supply Current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND, I <sub>OUT</sub> = 0, V <sub>CC</sub> = 3.6V			1	μA
Additional quiescent supply current	ΔI <sub>CC</sub>	One input at V <sub>CC</sub> - 0.6V, V <sub>CC</sub> = 2.7V to 3.6V, other inputs at V <sub>CC</sub> or GND			500	μA
Input Capacitance	C <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND, V <sub>CC</sub> = 3.3V		4.5		pF
Output Capacitance	C <sub>OUT</sub>	V <sub>OUT</sub> = V <sub>CC</sub> or GND, V <sub>CC</sub> = 3.3V		7		pF

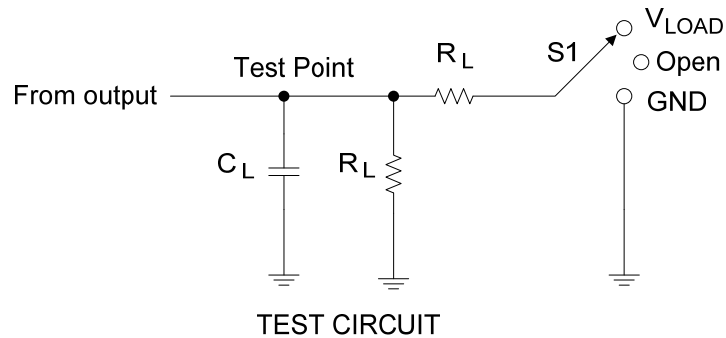
■ SWITCHING CHARACTERISTICS (T<sub>A</sub> =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from input A to output Y	t <sub>PD</sub>	V <sub>CC</sub> = 1.8V		13.2		ns
		V <sub>CC</sub> = 2.5V ±0.2V	1		7.2	
		V <sub>CC</sub> = 2.7V			5.2	
		V <sub>CC</sub> = 3.3V ±0.3V	1		4.7	
Propagation delay from input OE to output Y	t <sub>EN</sub>	V <sub>CC</sub> = 1.8V		14.3		ns
		V <sub>CC</sub> = 2.5V ±0.2V	1		8.3	
		V <sub>CC</sub> = 2.7V			6.3	
		V <sub>CC</sub> = 3.3V ±0.3V	1		5.7	
Propagation delay from input OE to output Y	t <sub>DIS</sub>	V <sub>CC</sub> = 1.8V		14.7		ns
		V <sub>CC</sub> = 2.5V ±0.2V	1		8.7	
		V <sub>CC</sub> = 2.7V			6.7	
		V <sub>CC</sub> = 3.3V ±0.3V	1.3		6	
Skew between any two outputs of the same package switching in the same direction	t <sub>SK(O)</sub>	V <sub>CC</sub> = 3.3V ±0.3V			1	ns

■ OPERATING CHARACTERISTICS (T<sub>A</sub> =25°C , unless otherwise specified)

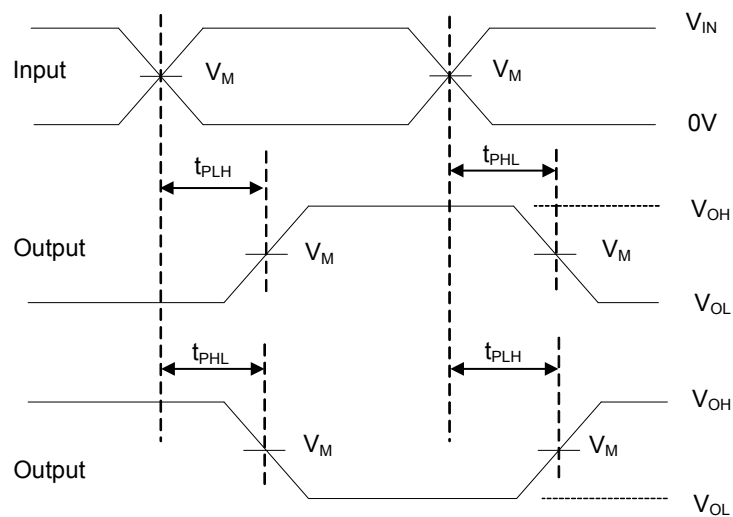
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power dissipation capacitance per gate	C <sub>PD</sub>	f=10MHz, Outputs enable	V <sub>CC</sub> = 1.8V	20		pF
			V <sub>CC</sub> = 2.5V	21		pF
			V <sub>CC</sub> = 3.3V	22		pF
		f=10MHz, Outputs disabled	V <sub>CC</sub> = 1.8V	2		pF
			V <sub>CC</sub> = 2.5V	3		pF
			V <sub>CC</sub> = 3.3V	4		pF

## TEST CIRCUIT AND WAVEFORMS



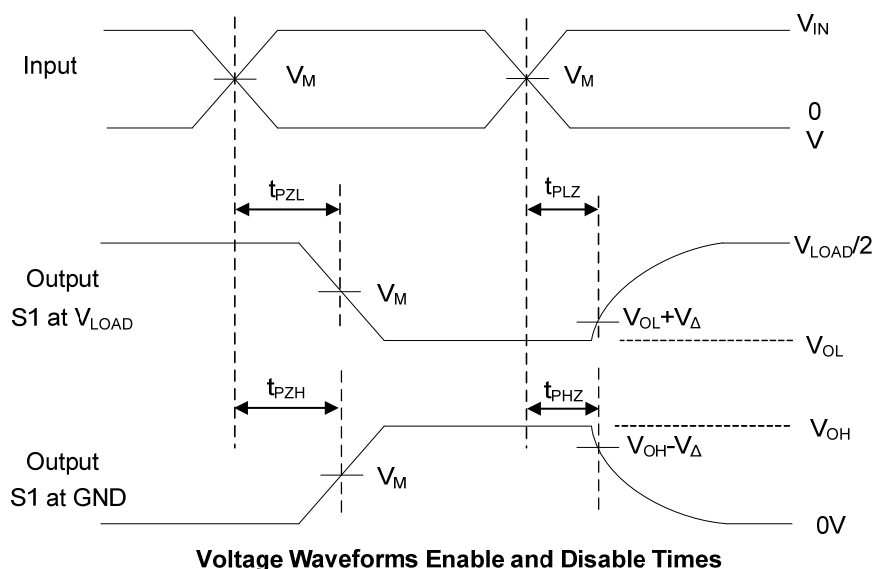
TEST	S1		
	$V_{CC} = 1.8V \pm 0.15V$	$V_{CC} = 2.5V \pm 0.2V$	$V_{CC} = 2.7V$ AND $3.3V \pm 0.3V$
$t_{PLH}/t_{PHL}$	Open	Open	Open
$t_{PLZ}/t_{PZL}$	$V_{LOAD}$	$V_{LOAD}$	6V
$t_{PHZ}/t_{PZH}$	GND	GND	GND

$V_{CC}$	Input		$V_M$	$V_{LOAD}$	$C_L$	$R_L$	$V_{\Delta}$
	$V_{IN}$	$t_R, t_F$					
$1.8V \pm 0.15V$	$V_{CC}$	$\leq 2ns$	$V_{CC}/2$	$2 * V_{CC}$	30pF	1k $\Omega$	0.15V
$2.5V \pm 0.2V$	$V_{CC}$	$\leq 2ns$	$V_{CC}/2$	$2 * V_{CC}$	30pF	500 $\Omega$	0.15V
2.7V	$V_{CC}$	$\leq 2ns$	1.5V	6V	50pF	500 $\Omega$	0.3V
$3.3V \pm 0.3V$	$V_{CC}$	$\leq 2ns$	1.5V	6V	50pF	500 $\Omega$	0.3V



Voltage Waveforms Propagation Delay Times

## ■ TEST CIRCUIT AND WAVEFORMS(Cont.)



Notes: 1.  $C_L$  includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR  $\leq 1$ MHz,  $Z_O = 50\Omega$ .
3.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{PD}$ .
4.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{EN}$ .
5.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{DIS}$ .

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